

#### **Features**

- Operating voltage range: 4.5V to 28V
- Load current limitation
- Output short-circuit protection
- Standby current <1.0µA
- On-state resistance Typ=23mΩ
- Thermal shutdown indication
- OFF-state open-load detection
- Overvoltage clamp
- Undervoltage protection
- Multiplexed analog feedback of load current with high precision proportional current mirror
- RoHS compliant and lead free
- AEC-Q100 qualified

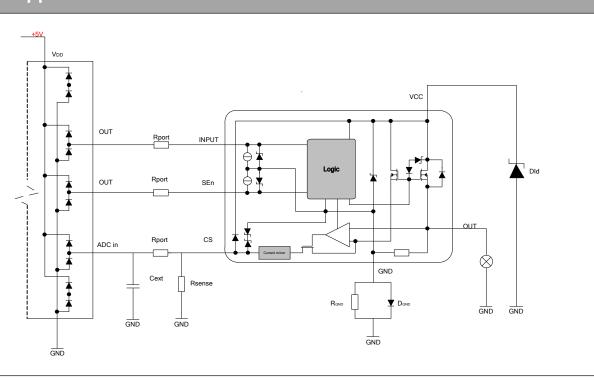
## General Description

- WS7020AF is single channel high-side drivers with current sense analog feedback for automotive applications, the devices are designed to drive 12 V automotive grounded loads through a 3 V and 5 V.
- WS7020AF integrates advanced protective functions such as load current limitation, overload active management by power limitation and overtemperature shutdown.
- A dedicated multifunction multiplexed analog output pin delivers sophisticated diagnostic functions including high precision proportional load current sense, in addition to the detection of overload and short circuit to ground, short to  $V_{\text{CC}}$ and OFF-state open-load.
- A sense enable pin allows OFF-state diagnosis to be disabled during the module low power mode as well as external sense resistor sharing among similar devices.
- WS7020AF is available in DFN5×6-14L package.

## **Application**

- All types of automotive resistive, inductive and capacitive loads
- Specially intended for automotive signal lamps

## **Typical Application Circuit**

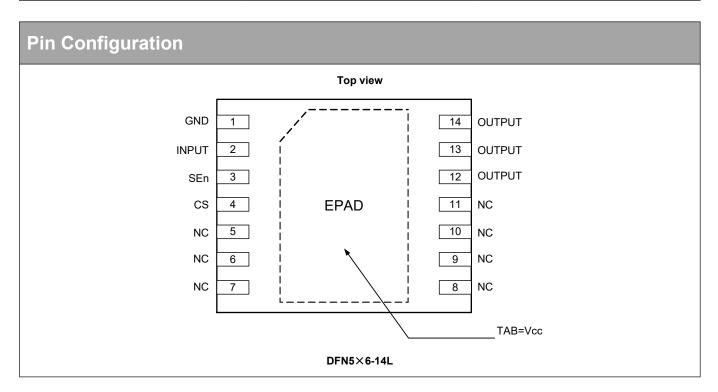


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Ordering Information		
Package	Top Mark	Part No.
14-Pin DFN5×6-14L, Pb-free	WS7020AF	WS7020AF
14-PIII DFN3 \ 0-14L, Pb-IIee	XXYMXX	WS/UZUAF



Pin Desci	ription	
Pin Name	Pin NO.	Pin Description
GND	1	Ground connection. Must be reverse battery protected by an external diode / resistor network.
INPUT	2	Voltage controlled input pin with hysteresis, compatible with 3 V and 5 V CMOS outputs. It controls output switch state.
SEn	3	Active high compatible with 3 V and 5 V CMOS outputs pin, it enables the CS diagnostic pin.
CS	4	Multiplexed analog sense output pin; it delivers a current proportional to the selected diagnostic:
NC	5/6/7/8/9/10/11	No connect.
OUTPUT	12/13/14	Power outputs.
V <sub>CC</sub>	EPAD	Battery connection.

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Table 1. Suggested connections for unused and not connected pins

Connection / pin	cs	NC	OUTPUT	INPUT	SEn
Floating	Not allowed	X <sup>(1)</sup>	Х	×	Х
To ground	Through 1K resistor	Х	Not allowed	Through 15K resistor	Through 15K resistor

Note1: X do not care.

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#### Absolute Maximum Ratings (Note3) Value Unit **Symbol Parameter** Vcc DC supply voltage 35 $-V_{\text{CC}}$ Reverse DC supply voltage 0.3 ٧ DC reverse ground pin current 200 -I<sub>GND</sub> mA Internally limited $I_{\text{OUT}}$ **OUTPUT DC output current** Α $V_{\text{IN}}, \, V_{\text{SEn}}$ INPUT, SEn DC input voltage -0.3 to 6.0 V CS pin DC output current 20 ISENSE mA CS pin DC output current in reverse -20 $T_{j}$ Junction operating temperature -40 to 150 $^{\circ}$ C $T_{\text{stg}}$ -55 to 150 Storage temperature

Note3: Stressing the device above the rating listed in Absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to the conditions in table below for extended periods may affect device reliability.

ESD Susceptibility (Note4)						
Symbol	Parameter	Values	Unit			
V <sub>ESD(HBM)</sub> <sup>3)</sup>	ESD Susceptibility all Pins (HBM)	±2	kV			
Vesd(HBM)_OUT	ESD Susceptibility OUT vs GND and Vcc connected (HBM)	±4	kV			
V <sub>ESD(CDM)</sub> <sup>4)</sup>	ESD Susceptibility all Pins (CDM)	±500	V			
Vesd(cdm)_crn	ESD Susceptibility Corner Pins (CDM) (pins 1, 8, 9, 16)	±750	V			

#### Note4:

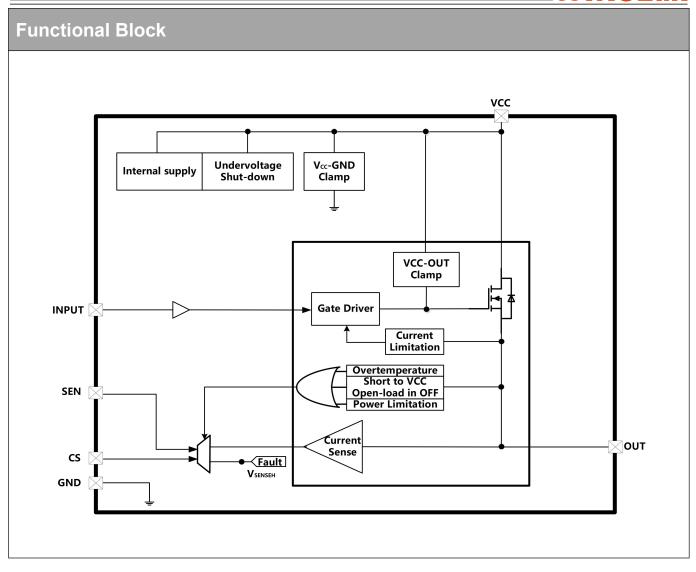
- 1) Not subject to production test specified by design.
- 2) Maximum digital input voltage to be considered for Latch-Up tests: 5.5 V.
- 3) ESD susceptibility, Human Body Model "HBM", according to AEC Q100-002.
- 4) ESD susceptibility, Charged Device Model "CDM", according to AEC Q100-011.

Thermal Resi	stance (Note5)		
Symbol	Parameter	Value	Unit
T <sub>JC</sub>	Thermal Resistance Junction-to-Case	1.3	°C/W
T <sub>JA</sub>	Junction-to-Ambient Thermal Resistance	28	°C/W

Note5: According to JEDEC JESD51-2,-5,-7 at natural convection on FR4 2s2p board; the Product (Chip + Package) was simulated on a 76.2  $\times$  114.3  $\times$  1.5 mm board with 2 inner copper layers (2  $\times$  70  $\mu$ m Cu, 2  $\times$  35  $\mu$ m Cu). Where applicable a thermal via array under the exposed pad contacted the first inner copper layer.

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## Electrical Characteristics (Note6)

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Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Operating supply voltage	Vcc		4.5	13	28	V
Under voltage shutdown	V <sub>USD</sub>				4.5	V
Under voltage shutdown reset	V <sub>USDReset</sub>				5	V
Under voltage shutdown hysteresis	V <sub>USDhyst</sub>			0.3		V
		I <sub>OUT</sub> =5A, T <sub>j</sub> = 25℃		23		
On-state resistance	Ron	I <sub>OUT</sub> =5A, T <sub>j</sub> =150℃			50	mΩ
		I <sub>OUT</sub> =5A, V <sub>CC</sub> =4.5V, T <sub>j</sub> = 25°C			40	
Nominal load current	I <sub>L(NOM)</sub>	T <sub>A</sub> =25℃		7.5		Α
Nominal load current at T <sub>A</sub> =85℃	I <sub>L(NOM)_85</sub>	T <sub>A</sub> =85℃, T <sub>j</sub> < 150℃		6.0		Α
Inverse Current Capability	I <sub>L(INV)</sub>	V <sub>CC</sub> <v<sub>OUT, V<sub>IN</sub>=5V, T<sub>A</sub>=25°C</v<sub>		7.5		Α
	V <sub>clamp</sub>	I <sub>s</sub> =20 mA, 25°C < T <sub>j</sub> < 150°C	35	42	48	V
V <sub>CC</sub> clamp voltage		I <sub>s</sub> =20 mA, T <sub>j</sub> =-40 °C	33			V
		V <sub>CC</sub> = 13V, V <sub>IN</sub> =V <sub>OUT</sub> =V <sub>SEn</sub> =0V,			1.0	
Supply current in standby st // = 12 //	,	T <sub>j</sub> =25℃			1.0	μA
Supply current in standby at V <sub>CC</sub> = 13 V	I <sub>STBY</sub>	V <sub>CC</sub> =13V, V <sub>IN</sub> =V <sub>OUT</sub> =V <sub>SEn</sub> =0V,			3.0	μA
		T <sub>j</sub> = 125℃			3.0	μΑ
Standby mode blanking time	t	V <sub>CC</sub> =13V, V <sub>IN</sub> =V <sub>OUT</sub> =0V	100	400	800	us
Standby mode blanking time	t <sub>D_STBY</sub>	V <sub>SEn</sub> =5 V to 0 V	100	400	800	us
Supply current	I <sub>S(ON)</sub>	V <sub>CC</sub> =13V, V <sub>SEn</sub> =0V, V <sub>IN</sub> =5V, I <sub>OUT</sub> =0A		3	6	mA
Control stage current consumption in ON	1	\\ -12\\ \\ -5			6	A
state	IGND(ON)	V <sub>CC</sub> =13V, V <sub>SEn</sub> =5V, V <sub>IN</sub> =5V, I <sub>OUT</sub> =5A			0	mA
Off state output ourrent at V = 12V	L	$V_{\text{IN}}$ = $V_{\text{OUT}}$ =0 $V$ , $V_{\text{CC}}$ =13 $V$ , $T_{j}$ =25 $^{\circ}$ C	0	0.05	0.5	μA
Off-state output current at V <sub>CC</sub> =13V	$I_{L(off)}$	V <sub>IN</sub> =V <sub>OUT</sub> =0V, V <sub>CC</sub> =13V, T <sub>j</sub> =125°C	0		3.0	μA
Output - V <sub>CC</sub> diode voltage at T <sub>j</sub> =150℃	V <sub>F</sub>	I <sub>OUT</sub> =-0.2A, T <sub>j</sub> =150℃			0.9	V

#### Switching/V<sub>cc</sub> = 13 V, -40 $^{\circ}$ C < T<sub>j</sub>< 150 $^{\circ}$ C, unless otherwise specified

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Turn-on delay time at T <sub>j</sub> = 25℃	T <sub>d (on)</sub>	- R <sub>ι</sub> =2.6Ω	10	40	120	us
Turn-off delay time at T <sub>j</sub> = 25°C	T <sub>d (off)</sub>	RL-2.012	10	75	120	us
Turn-on voltage slope at T <sub>j</sub> = 25℃	(dV <sub>OUT</sub> /dt) <sub>on</sub>	- R <sub>i</sub> =2.6Ω	0.05	0.2	0.7	V/us
Turn-off voltage slope at T <sub>j</sub> = 25 ℃	(dV <sub>OUT</sub> /dt) <sub>off</sub>	RL-2.012	0.05	0.25	0.7	V/us
Differential pulse skew(t <sub>PHL</sub> - t <sub>PLH</sub> )	tskew	R <sub>L</sub> =2.6Ω	-90	-	60	us

## Logic input (IN, SEn)

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Logic input low level voltage	$V_L$				0.9	V
Low level logic input current	lι	V <sub>INL</sub> =0.9V	0.5			uA
Logic input high level voltage	V <sub>H</sub>		2.1		6.0	V
High level logic input current	l <sub>H</sub>	V <sub>INH</sub> =2.1V			12	uA
Logic input hysteresis voltage	V <sub>(hyst)</sub>		0.1	0.3	0.7	V

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Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Uni	
	- <b>,</b>	V <sub>CC</sub> =13V	12	24	36		
DC short circuit current	I <sub>LIMH</sub>	4.5V < V <sub>CC</sub> < 18V			36	Α	
Short circuit current during themal cycling	I <sub>LIML</sub>	V <sub>CC</sub> =13V, T <sub>R</sub> < T <sub>j</sub> < T <sub>TSD</sub>		9			
Shutdown temperature	T <sub>TSD</sub>		150	175	200	°C	
Thermal hysteresis	T <sub>HYST</sub>			20		°C	
Dynamic temperature	$\Delta T_{\text{J\_SD}}$	T <sub>j</sub> = -40℃, V <sub>CC</sub> =13V		60		°C	
Current limit thermal hysteresis	T <sub>R</sub>			40		°C	
Turn-off output voltage clamp	V	I <sub>OUT</sub> =2A, L= 6mH, T <sub>j</sub> = -40 °C	Vcc-33			V	
rum-on output voltage clamp	$V_{DEMAG}$	$I_{OUT}$ =2A, L= 6mH, $T_j$ =25 $^{\circ}$ C to 150 $^{\circ}$ C	Vcc-35	Vcc-38	Vcc-43	V	
Current sense / 7 V < V <sub>cc</sub> < 18 V	, -40℃ < T <sub>j</sub> <	< 150℃					
Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Uni	
Current sonso clama voltago	V	V <sub>SEn</sub> =0V, I <sub>SENSE</sub> =1mA		-15		V	
Current sense clamp voltage	V <sub>SENSE_CL</sub>	V <sub>SEn</sub> =0V, I <sub>SENSE</sub> = -1mA		7		<b>V</b>	
Current sense characteristics							
Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Un	
OUT/Isense	<b>K</b> <sub>1</sub>	I <sub>OUT</sub> =0.5A, V <sub>SEn</sub> =5V	-50%	2100	+50%		
lout/I <sub>SENSE</sub>	K <sub>2</sub>	I <sub>OUT</sub> =1A, V <sub>SEn</sub> =5V	-30%	2680	+30%		
lout/I <sub>SENSE</sub>	K <sub>3</sub>	I <sub>OUT</sub> =3A, V <sub>SEn</sub> =5V	-15%	3160	+15%		
lout/Isense	K <sub>4</sub>	I <sub>OUT</sub> =8A, V <sub>SEn</sub> =5V	-10%	3360	+10%		
		CS disabled: V <sub>SEn</sub> =0V	0		0.5		
Current sense leakage current		CS disabled: -1V <v<sub>SENSE&lt;5V</v<sub>	-0.5		3	uA	
	I <sub>SENSE0</sub>	CS enabled: V <sub>SEn</sub> =5V, V <sub>IN</sub> = 5V, I <sub>OUT</sub> =0A	0		200		
		CS enabled: V <sub>SEn</sub> =5V, V <sub>IN</sub> = 0V, I <sub>OUT</sub> =0A	0		2		
Output voltage for CS shutdown	V <sub>OUT_MSD</sub>	V <sub>SEn</sub> =5V, R <sub>SENSE</sub> =2.7K, V <sub>IN</sub> =5V;I <sub>OUT</sub> =5A		5		V	
CS saturation voltage	V <sub>SENSE_SAT</sub>	V <sub>CC</sub> =7V, R <sub>SENSE</sub> =2.7K,V <sub>SEn</sub> =5V,V <sub>IN</sub> =5V, $I_{OUT}$ =16A, $T_j$ =150 °C	5			٧	
CS saturation current	ISENSE_SAT	$V_{CC}$ =7V, $V_{SENSE}$ =4V, $V_{IN}$ =5V, $V_{SEn}$ =5V, $T_{j}$ =150°C	4			m/	
Output saturation current	lout_sat	$V_{CC}$ =7V, $V_{SENSE}$ =4V, $V_{IN}$ =5V, $V_{SEn}$ =5V $T_{J}$ =150 $^{\circ}$ C	20			Α	
OFF-state diagnostic							
Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Un	
OFF-state open load voltage detection	V <sub>OL</sub>	V <sub>SEn</sub> =5V, V <sub>IN</sub> =0V	2	3	4	V	
OFF-state output sink current	I <sub>L(off2)</sub>	$V_{IN}$ = 0 V, $V_{OUT}$ = $V_{OL}$ , $T_j$ = -40 $^{\circ}$ C to 150 $^{\circ}$ C	-900	-400	-160	u/	
OFF-state diagnostic delay time from		V <sub>SEn</sub> =5V, V <sub>IN</sub> = 5V to 0 V, V <sub>OUT</sub> =4V	100		700		

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# WS7020AF Product Description High-side driver with current sense analog feedback for automotive applications



Settling time for valid OFF-state open load diagnostic indication from rising edge of SEn	t <sub>D_OL_V</sub>	V <sub>IN</sub> =0V,V <sub>OUT</sub> =4V, V <sub>SEn</sub> = 0V to 5V			150	us	
OFF-state diagnostic delay time from rising edge of V <sub>OUT</sub>	t <sub>D_VOL</sub>	V <sub>SEn</sub> =5V,V <sub>IN</sub> =0V, V <sub>OUT</sub> =0V to 4V		5	30	us	
Fault diagnostic feedback							
Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit	
Current sense output voltage in fault condition	Vsenseh	$V_{CC}$ =13V, $R_{SENSE}$ =1K, $V_{IN}$ =0V, $V_{SEn}$ = 5V, $I_{OUT}$ =0A, $V_{OUT}$ =4V	5.0	6.0	6.6	V	
Current sense output current in fault condition	I <sub>SENSEH</sub>	V <sub>CC</sub> =13V, V <sub>SENSE</sub> =5V	10	20	30	mA	
Current sense timings							
Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit	
Current sense settling time from rising		V <sub>IN</sub> =5V, V <sub>SEn</sub> =0V to 5V,					
edge of SEn	t <sub>DSENSE1H</sub>	$R_{SENSE}$ =1K, $R_L$ =2.6 $\Omega$			100	us	
edge of SEn  Current sense disable delay time from falling edge of SEn	t <sub>DSENSE1H</sub>	R <sub>SENSE</sub> =1K, R <sub>L</sub> =2.6 $\Omega$ V <sub>IN</sub> =5V, V <sub>SEn</sub> =5V to 0V, R <sub>SENSE</sub> =1K, R <sub>L</sub> =2.6 $\Omega$		5	100	us us	
Current sense disable delay time from	_	V <sub>IN</sub> =5V, V <sub>SEn</sub> =5V to 0V,		5			
Current sense disable delay time from falling edge of SEn  Current sense settling time from rising	t <sub>DSENSE1L</sub>	$V_{\text{IN}}=5\text{V, V}_{\text{SEn}}=5\text{V to 0V,}$ $R_{\text{SENSE}}=1\text{K, R}_{\text{L}}=2.6\Omega$ $V_{\text{IN}}=0\text{V to 5V, V}_{\text{SEn}}=5\text{ V,}$		-	20	us	

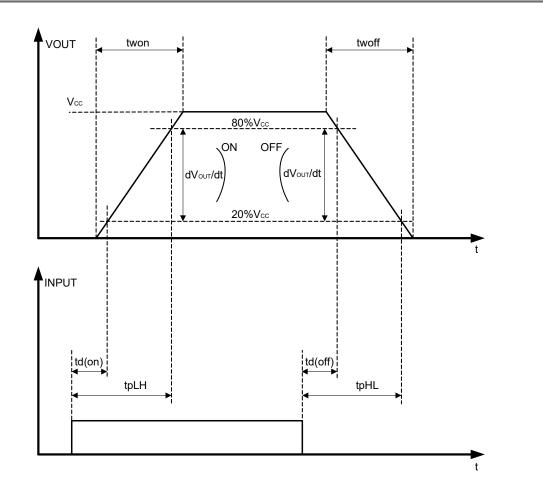
Note6: Except for the special test instructions, all electrical parameters are tested under TA= +25 °C. The minimum and maximum specification range of the specifications is guaranteed by the test, and the typical values are guaranteed by the design, test, or statistical analysis.

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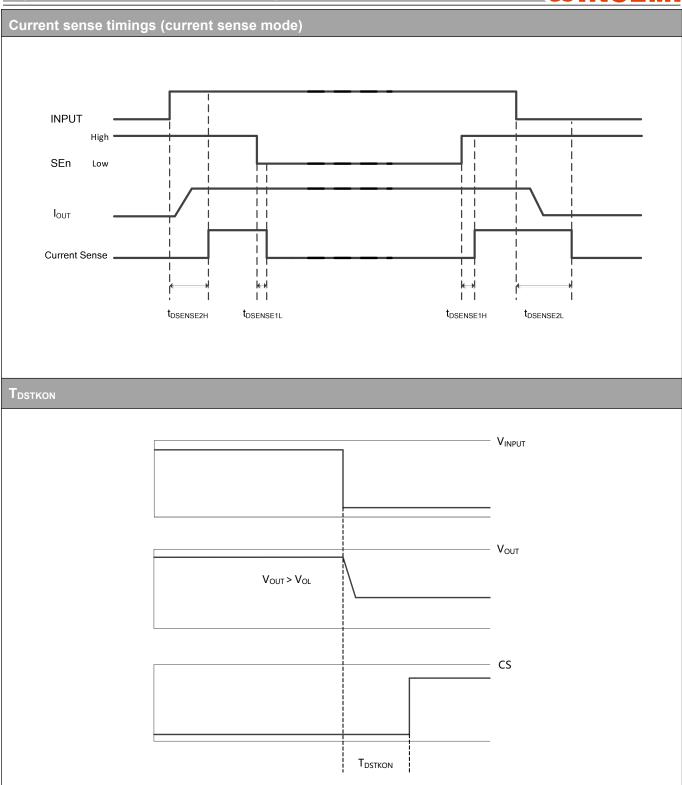
## **Switching Status and Timing Relationship**

Switching time and pulse skew



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#### Table 2. Truth table

Mode	Conditions	IN	SEn	OUT	Current sense	Comments
Standby	All logic INs low	L	L	L	Hi-Z	Low quiescent current consumption
	Nominal load connected;	L	See	L	See Table 3	
Normal	T <sub>j</sub> < 150°C	Н	Table 3	Н	See Table 3	Outputs configured for auto-restart
	Overload or short to GND	L		L	See Table 3	
Overload	causing: $T_{j} > T_{TSD} \text{ or }$ $\Delta T_{j} > \Delta T_{j\_SD}$	Н	See Table 3	Н	See Table 3	Output cycles with temperature hysteresis
Undervoltage	V <sub>CC</sub> <v<sub>USD</v<sub>	Х	Х	L	Hi-Z	Re-start when $V_{CC} > V_{USD} + V_{USDhyst}$ (rising )
OFF-state	Short to V <sub>CC</sub>	L	See	Н	See Table 3	
diagnostics	Open-Load	L	Table 3	Н	See Table 3	External pull-up
Negative output voltage	Inductive loads turn-off	L	See Table 3	<0	See Table 3	

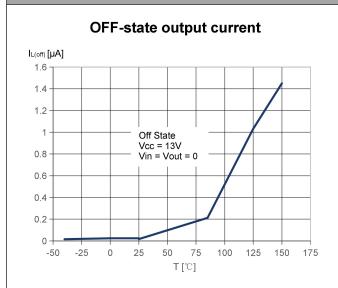
#### Table 3. Current sense output

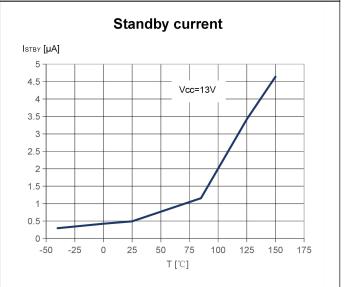
SEn	MUX Channel	Current sense output			
		Normal	Overload	OFF-state	Negative output
L		Hi-Z			
Н	Channel diagnostic	I <sub>SENSE</sub> = I <sub>OUT</sub> /K	V <sub>SENSE</sub> = V <sub>SENSEH</sub>	V <sub>SENSE</sub> = V <sub>SENSEH</sub>	Hi-Z

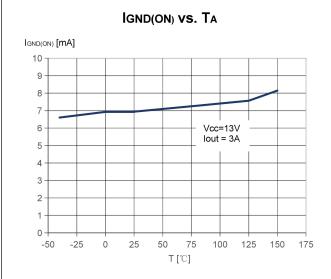
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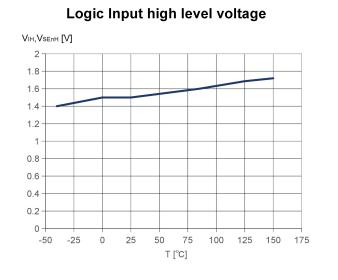


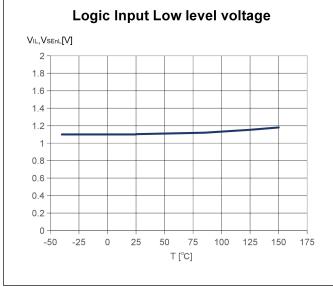
## **Electrical Characteristics Curves**

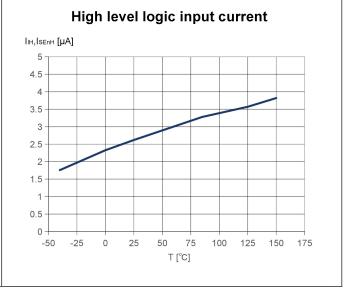








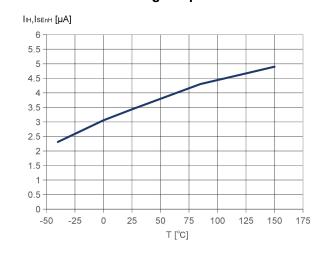




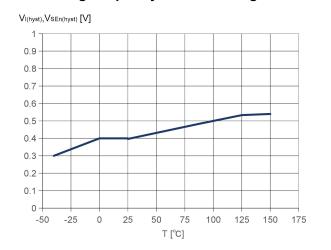
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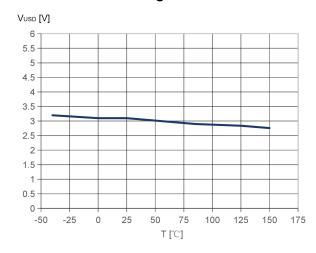
#### Low level logic input current



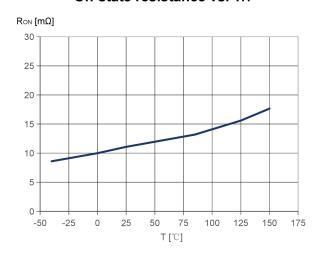
#### Logic Input hysteresis voltage



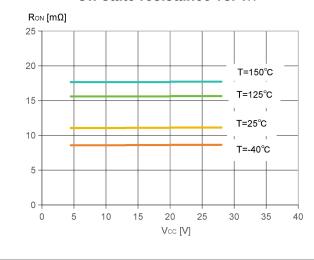
#### Undervoltage shutdown



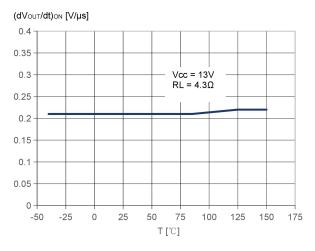
#### On-state resistance vs. TA



#### On-state resistance vs. TA



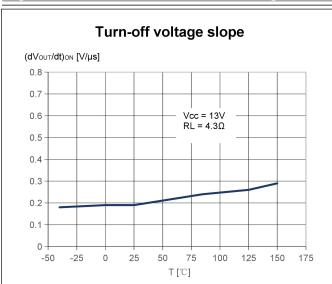
#### Turn-on voltage slope

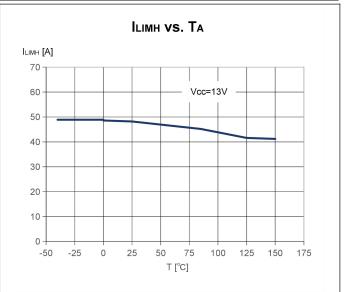


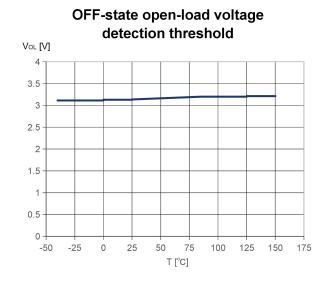
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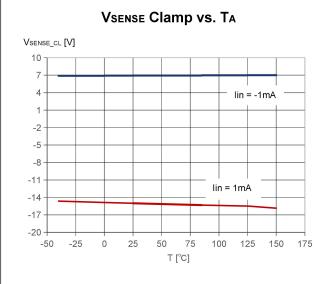


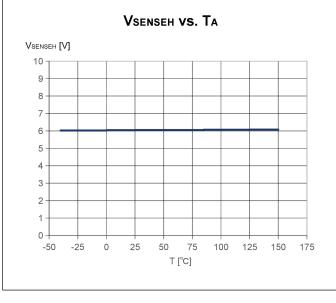


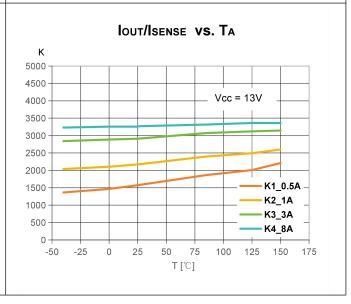












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#### WS7020AF Product Description

High-side driver with current sense analog feedback for automotive applications



#### **Functional Description**

#### **Power limitation**

The basic working principle of this protection consists of an indirect measurement of the junction temperature swing  $\Delta T_j$  through the direct measurement of the spatial temperature gradient on the device surface in order to automatically shut off the output MOSFET as soon as  $\Delta T_j$  exceeds the safety level of  $\Delta T_{j\_SD}$ . The protection prevents fast thermal transient effects and, consequently, reduces thermo-mechanical fatigue.

#### Thermal shutdown

In case the junction temperature of the device exceeds the maximum allowed threshold (typically 175  $^{\circ}$ C), it automatically switches off and the diagnostic indication is triggered.

#### **Current limitation**

The device is equipped with an output current limiter in order to protect the silicon as well as the other components of the system (e.g. bonding wires, wiring harness, connectors, loads, etc.) from excessive current flow. Consequently, in case of short circuit, overload or during load power-up, the output current is clamped to a safety level, I<sub>LIMH</sub>, by operating the output power MOSFET in the active region.

#### **Negative voltage clamp**

In case the device drives inductive load, the output voltage reaches a negative value during turn off. A negative voltage clamp structure limits the maximum negative voltage to a certain value, V<sub>DEMAG</sub>, allowing the inductor energy to be dissipated without damaging the device.

#### Diode (D<sub>GND</sub>) in the ground line

A resistor (typ.R<sub>GND</sub>=4.7K) should be inserted in parallel to D<sub>GND</sub> if the device drives an inductive load. This small signal diode can be safely shared amongst several different HSDs. Also in this case, the presence of the ground network produces a shift ( $\approx$ 600mV) in the input threshold and in the status output values if the microprocessor ground is not common to the device ground. This shift does not vary if more than one HSD shares the same diode/resistor network.

#### MCU I/Os protection

If a ground protection network is used and negative transients are present on the  $V_{CC}$  line, the control pins will be pulled negative. WS suggests to insert a resistor ( $R_{prot}$ =15K) in line both to prevent the micro-controller I/O pins from latching-up and to protect the HSD inputs. The value of these resistors is a compromise between the leakage current of micro-controller and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of micro-controller I/Os.

#### CS - analog current sense

Diagnostic information on device and load status are provided by an analog output pin (CS) delivering the following signals:

- · Current monitor: current mirror of channel output current
- V<sub>CC</sub> monitor: voltage proportional to V<sub>CC</sub>
- T<sub>CASE</sub>: voltage proportional to chip temperature

Those signals are routed through an analog multiplexer which is configured and controlled by means of SELx and SEn pins, according to the address map in CS multiplexer addressing Table.

#### **Current monitor**

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## WS7020AF Product Description





When current mode is selected in the CS, this output is capable to provide:

- Current mirror proportional to the load current in normal operation, delivering current proportional to the load according to known ratio named K
- Diagnostics flag in fault conditions delivering fixed voltage V<sub>SENSEH</sub>

The current delivered by the current sense circuit, I<sub>SENSE</sub> can be easily converted to a voltage V<sub>SENSE</sub> by using an external sense resistor, R<sub>SENSE</sub>, allowing continuous load monitoring and abnormal condition detection.

While device is operating in normal conditions (no fault intervention), V<sub>SENSE</sub> calculation can be done using simple equations.

Current provided by CS output: Isense = Iout/K

Voltage on Rsense: Vsense = Rsense\*Isense = Rsense\* Iout/K

#### Where:

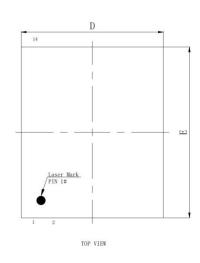
- V<sub>SENSE</sub> is voltage measurable on R<sub>SENSE</sub> resistor
- I<sub>SENSE</sub> is current provided from CS pin in current output mode

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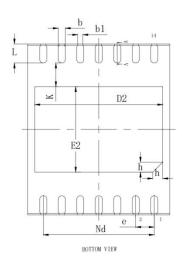


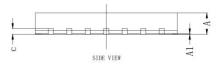
## Package Outline

## **DFN5**×6-14L











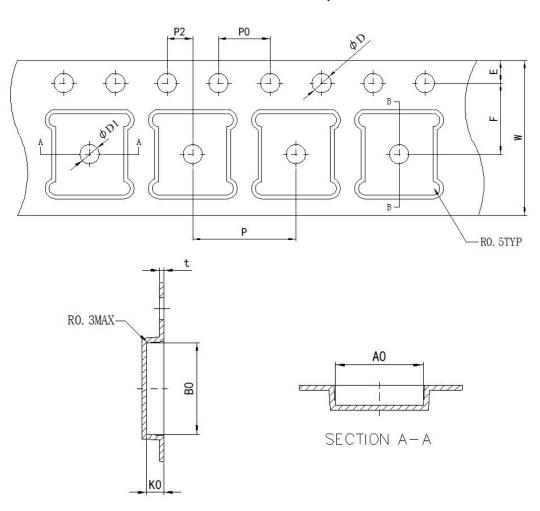
	MILLIMETER				
SYMBOL	MIN	NOM	MAX		
Α	0.70	0.75	0.80		
A1	0	0.02	0.05		
b	0.20	0.25	0.30		
b1	0.18REF				
С	0.203REF				
D	4.90 5.00		5.10		
D2	4.40	4.50	4.60		
е					
Nd	3.90BSC				
E	5.90	6.00	6.10		
E2	2.90	3.00	3.10		
L	0.62	0.67	0.72		
h	0.30	0.35	0.40		
K	0.83REF				
W <sub>SC</sub>	0.01	-	0.09		
t <sub>sc</sub>	0.08	-	0.18		

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## Tape and Reel Information

DFN5×6-14L Carrier tape



SECTION B-B

Billo o lie damei i	<u>'</u>		
Description	Value (Unit: mm)		
E	1.75±0.10		
F	5.50±0.05		
P2	2.00±0.05		
D	1.50±0.1		
D1	1.50 MIN		
P0	4.00±0.10		
W	12.00±0.1		
Р	8.00±0.10		
A0	5.30±0.10		
В0	6.30±0.10		
КО	1.20±0.10		

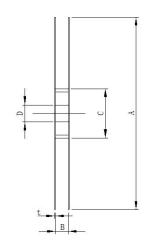
DFN5×6-14L Carrier Tape Dimensions

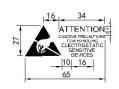
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#### DFN5×6-14L Reel (13 ")









DFN5×6-14L Reel Dimensions

Description	Value (Unit: mm)
Carrier width	12
А	329±1
В	12.4+2
С	100±1
D	13.3±0.3
t	2.0±0.3

#### Tape and Reel Information

Package	Reel	QTY/Reel	Reel/Inner Box	Inner Box/Carton	QTY/Carton	Inner Box Size (mm)	Carton Size (mm)
DFN5×6-14L	13 "	3000	1	8	24000	336×336×48	420×355×365

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## WS7020AF Product Description

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#### CONTACT

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